

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
			Examiner Laura S Weiner	Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,712,057	01-1998	Fauteux, Denis G.	429/213
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP 7-335254	12-1995	Japan	Yamamoto et al.	
	O				Translation	
	P					
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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